

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- Green Device Available

Product Summary



V_{DS}	-30	V
I_D	-45	A
$R_{DS(ON)}$ (at $V_{GS}=-10V$)	15	mΩ
$R_{DS(ON)}$ (at $V_{GS}=-4.5V$)	25	mΩ

Applications

- High Frequency Point-of-Load, Synchronous Buck Converter
- Networking DC-DC Power System
- Load Switch



Absolute Maximum Ratings($T_c=25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Rating		Units
		10S	Steady State	
Drain-Source Voltage	V_{DS}		-30	V
Gate-Source Voltage	V_{GS}		± 25	V
Continuous Drain Current, $V_{GS} @ -10V^1$	$I_D @ T_c=25^\circ\text{C}$		-45	A
Continuous Drain Current, $V_{GS} @ -10V^1$	$I_D @ T_c=100^\circ\text{C}$		-30	A
Continuous Drain Current, $V_{GS} @ -10V^1$	$I_D @ T_A=25^\circ\text{C}$	-15	-9.6	A
Continuous Drain Current, $V_{GS} @ -10V^1$	$I_D @ T_A=70^\circ\text{C}$	-12	-7.7	A
Pulsed Drain Current ²	I_{DM}		-150	A
Single Pulse Avalanche Energy ³	EAS		125	mJ
Avalanche Current	I_{AS}		-50	A
Total Power Dissipation ⁴	$P_D @ T_c=25^\circ\text{C}$		45	W
Total Power Dissipation ⁴	$P_D @ T_A=25^\circ\text{C}$	5	2	W
Storage Temperature Range	T_{STG}		-55 to 150	°C
Operating Junction Temperature Range	T_J		-55 to 150	°C

Thermal Characteristics

Parameter	Symbol	Typ	Max	Unit
Thermal Resistance Junction-Ambient ¹ ($t \leq 10s$)	$R_{\theta JA}$	---	25	°C/W
Thermal Resistance Junction-Ambient ¹		---	62	°C/W
Thermal Resistance Junction-Case ¹	$R_{\theta JC}$	---	2.8	°C/W

Electrical Characteristics (T_J=25°C, unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =-250µA	-30	---	---	V
BV _{DSS} Temperature Coefficient	△BV _{DSS} /△T _J	Reference to 25°C, I _D =-1mA	---	-0.023	---	V/°C
Static Drain-Source On-Resistance ²	R _{DS(ON)}	V _{GS} =-10V, I _D =-30A	---	---	15	mΩ
		V _{GS} =-4.5V, I _D =-15A	---	---	25	mΩ
Gate Threshold Voltage	V _{GS(th)}	V _{GS} =V _{DS} , I _D =-250µA	-1.0	---	-2.5	V
V _{GS(th)} Temperature Coefficient	△V _{GS(th)}		---	4.6	---	mV/°C
Drain-Source Leakage Current	I _{DSS}	V _{DS} =-24V, V _{GS} =0V, T _J =25°C	---	---	-1	µA
		V _{DS} =-24V, V _{GS} =0V, T _J =55°C	---	---	-5	µA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =±25V, V _{DS} =0V	---	---	±100	nA
Forward Transconductance	g _{fs}	V _{DS} =-5V, I _D =-30A	---	30	---	S
Gate Resistance	R _g	V _{DS} =0V, V _{GS} =0V, f=1MHz	---	9	---	Ω
Total Gate Charge	Q _g	V _{DS} =-15V, V _{GS} =-4.5V, I _D =-15A	---	22	---	nC
Gate-Source Charge	Q _{gs}		---	8.7	---	
Gate-Drain Charge	Q _{gd}		---	7.2	---	
Turn-On Delay Time	T _{d(on)}	V _{DD} =-15V, V _{GS} =-10V, R _G =3.3Ω, I _D =-15A	---	8	---	ns
Rise Time	T _r		---	73.7	---	
Turn-Off Delay Time	T _{d(off)}		---	61.8	---	
Fall Time	T _f		---	24.4	---	
Input Capacitance	C _{iss}	V _{DS} =-15V, V _{GS} =0V, f=1MHz	---	2215	---	pF
Output Capacitance	C _{oss}		---	310	---	
Reverse Transfer Capacitance	C _{rss}		---	237	---	

Drain-Source Diode Characteristics

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Continuous Source Current ^{1,5}	I _S	V _G =V _D =0V, Force Current	---	---	-45	A
Pulsed Source Current ^{2,5}	I _{SM}		---	---	-150	A
Diode Forward Voltage ²	V _{SD}	V _{GS} =0V, I _S =-1A, T _J =25°C	---	---	-1	V
Reverse Recovery Time	t _{rr}	I _F =-15A, di/dt=100A/µs, T _J =25°C	---	19	---	nS
	Q _{rr}		---	9	---	nC

Note:

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%
- 3.The EAS data shows Max. rating . The test condition is V_{DD}=-25V,V_{GS}=-10V,L=0.1mH
- 4.The power dissipation is limited by 150°C junction temperature
- 5.The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

Typical Characteristics

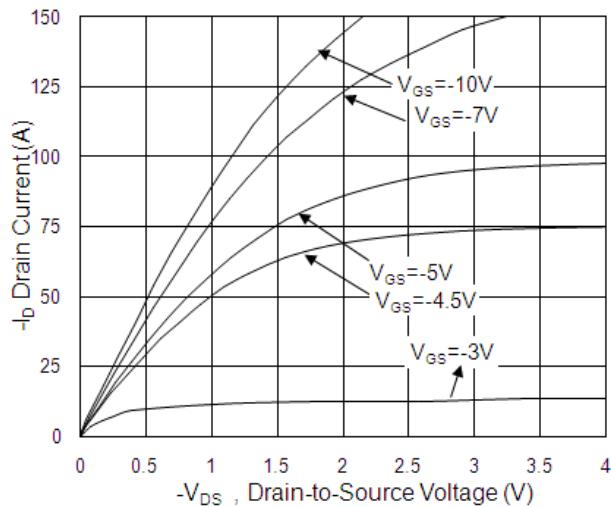


Fig.1 Typical Output Characteristics

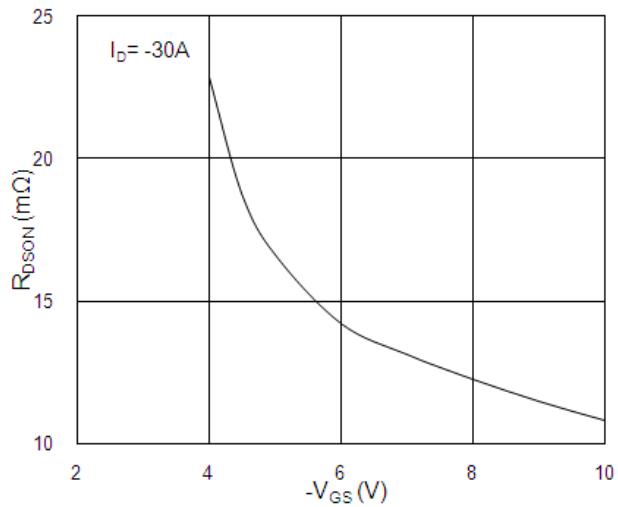


Fig.2 On-Resistance vs. G-S Voltage

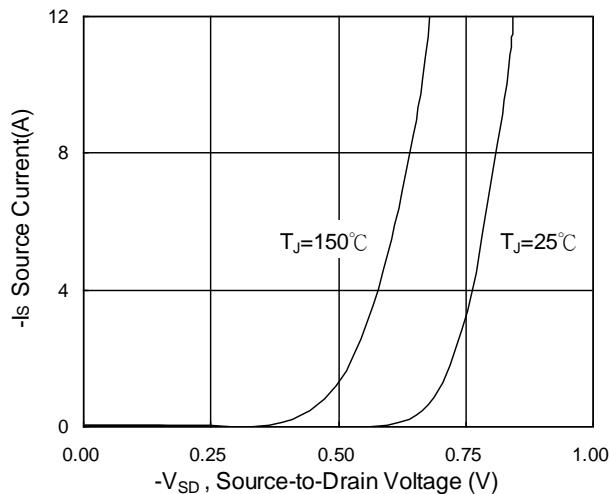


Fig.3 Forward Characteristics of Reverse

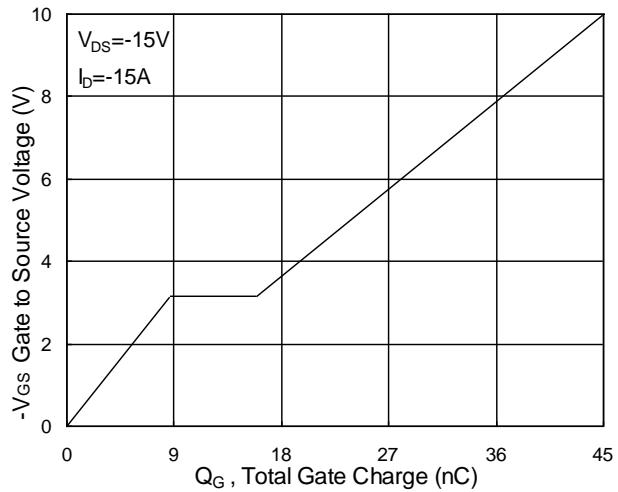


Fig.4 Gate-charge Characteristics

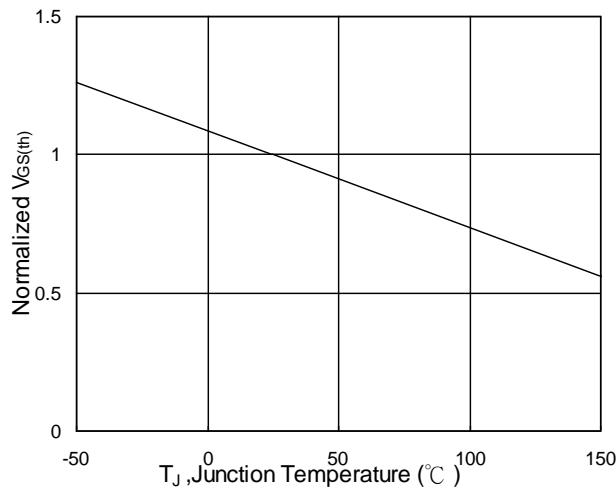


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

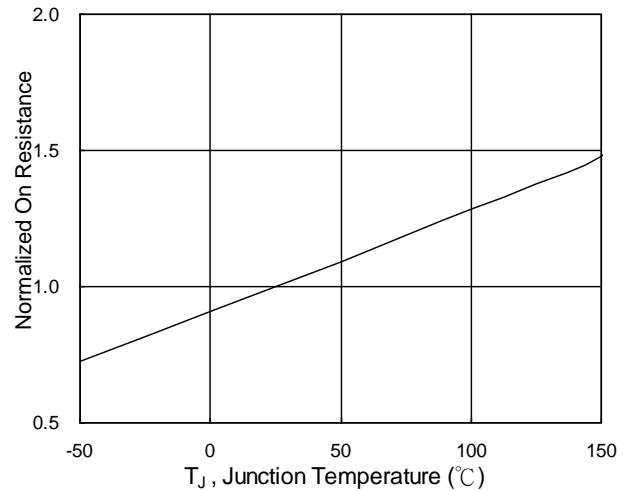
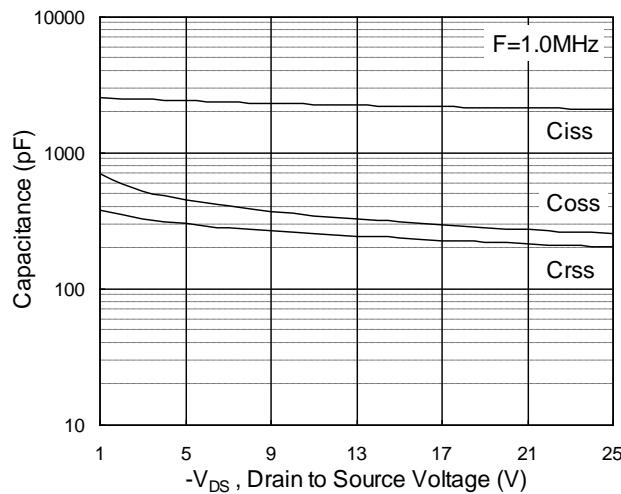
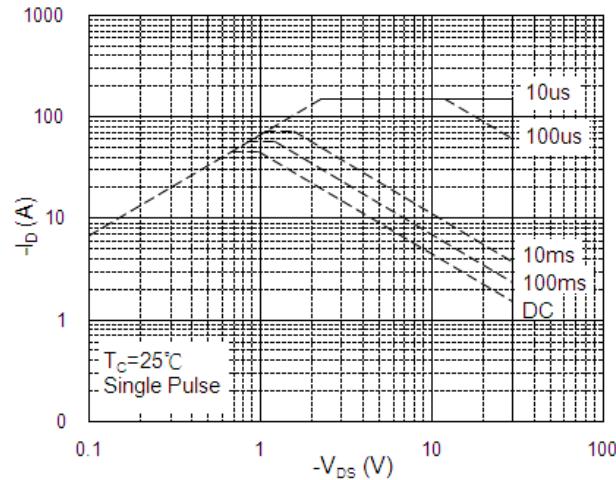
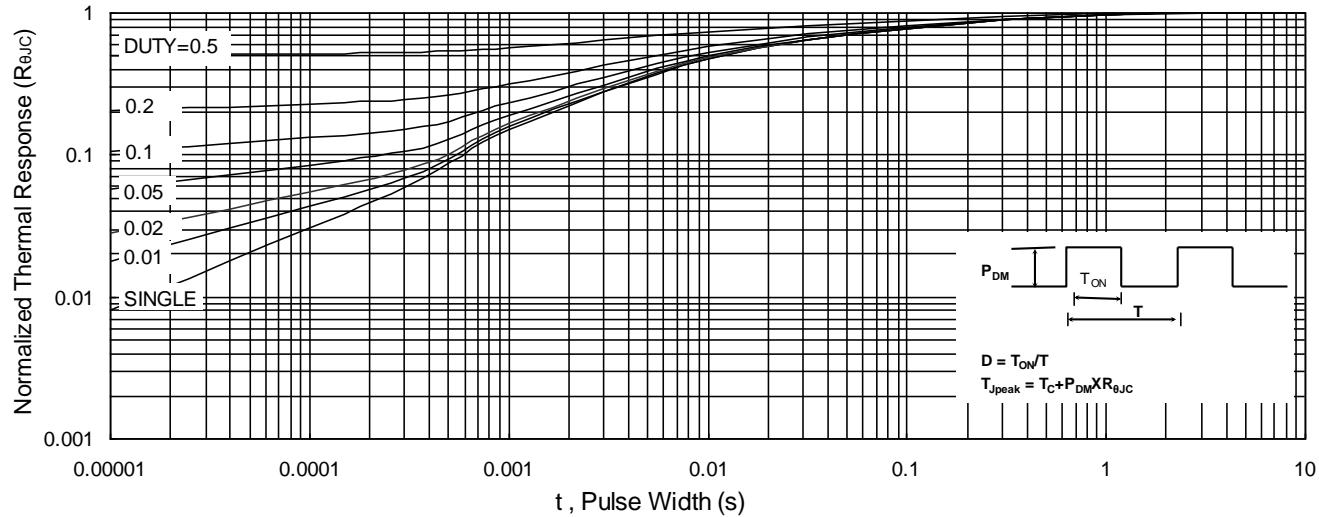
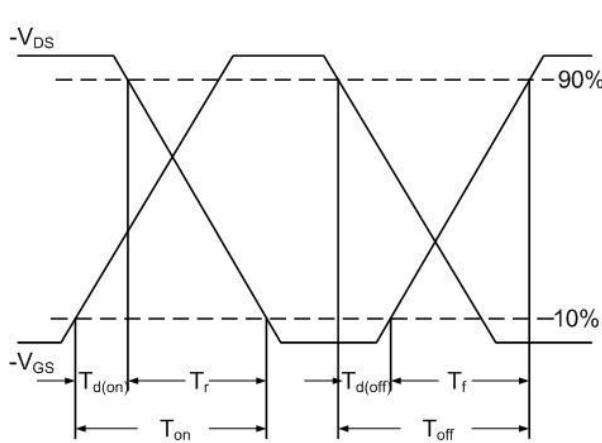
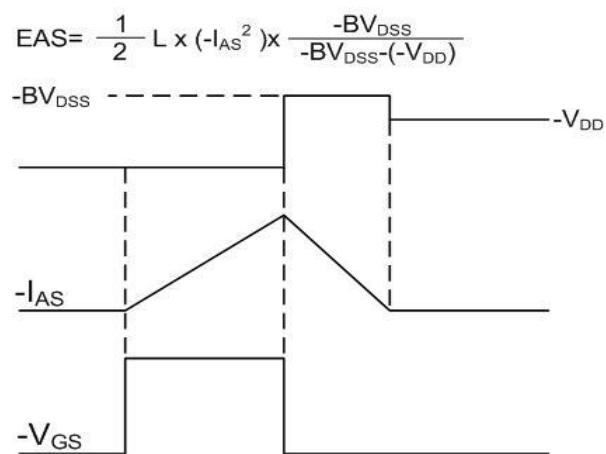
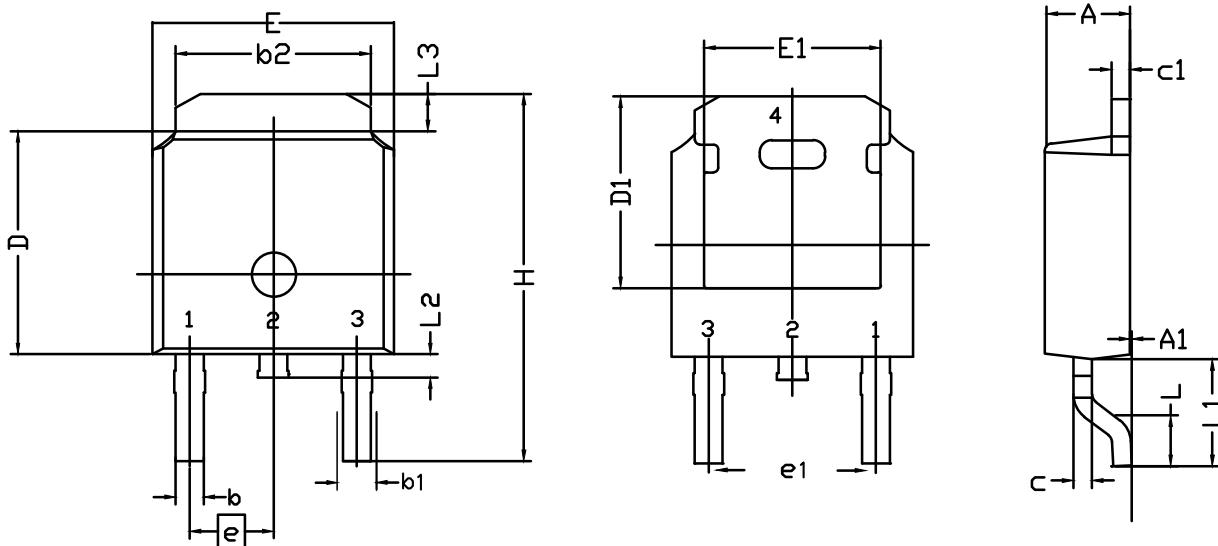


Fig.6 Normalized $R_{DS(on)}$ vs. T_J


Fig.7 Capacitance

Fig.8 Safe Operating Area

Fig.9 Normalized Maximum Transient Thermal Impedance

Fig.10 Switching Time Waveform

Fig.11 Unclamped Inductive Switching Waveform

TO-252 Package Outline Dimensions



Symbol	Dimensions (unit:mm)			Symbol	Dimensions (unit:mm)		
	Min	Typ	Max		Min	Typ	Max
A	2.20	2.30	2.38	E	6.40	6.60	6.731
A₁	0.00	0.10	0.20	E₁	4.40	--	--
b	0.64	0.76	0.89	e	2.286 BSC		
b₁	0.77	0.85	1.14	e₁	4.572 BSC		
b₂	5.00	5.33	5.46	H	9.40	10.00	10.40
c	0.458	0.508	0.610	L	1.40	1.52	1.77
C₁	0.458	0.508	0.620	L₁	--	2.743	--
D	5.98	6.10	6.223	L₂	0.60	0.80	1.01
D₁	5.20	5.25	5.38	L₃	0.90	1.06	1.25